AUTOMOTIVE CURRENT TRANSDUCER OPEN LOOP TECHNOLOGY
HAH1BVW S/04

Introduction

The HAH1BVW family is for the electronic measurement of DC, AC or pulsed currents in high power and low voltage automotive applications with galvanic separation between the primary circuit (high power) and the secondary circuit (electronic circuit).

The HAH1BVW family gives you the choice of having different current measuring ranges in the same housing.

Features

- Ratiometric transducer
- Open Loop transducer using the Hall effect
- Low voltage application
- Unipolar +5 V DC power supply
- Primary current measuring range ±400 A
- Maximum RMS primary admissible current: defined by busbar to have T < +150 °C
- Operating temperature range: −40 °C < T < 125 °C
- Output voltage: full ratio-metric (in sensitivity and offset).

Advantages

- Excellent accuracy
- Very good linearity
- Very low thermal offset drift
- Very low thermal sensitivity drift
- Galvanic separation
- Non intrusive solution.

Automotive application

- Battery Management.

Principle of HAH1BVW Family

The open loop transducers uses a Hall effect integrated circuit. The magnetic flux density B, contributing to the rise of the Hall voltage, is generated by the primary current I_P to be measured.

The current to be measured I_P is supplied by a current source i.e. battery or generator (Figure 1).

Within the linear region of the hysteresis cycle, B is proportional to:

$$B\ (I_P) = a \times I_P$$

The Hall voltage is thus expressed by:

$$U_H = (c_H\ /\ d) \times I_H \times a \times I_P$$

Except for I_P, all terms of this equation are constant. Therefore:
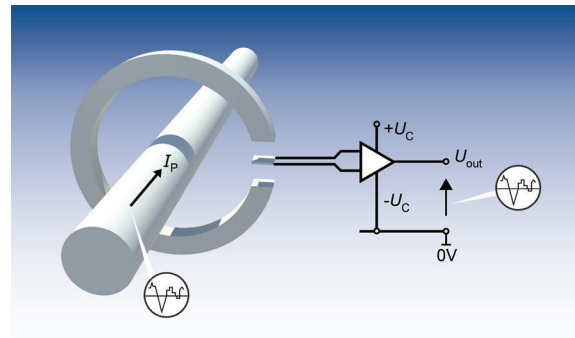
$$U_H = b \times I_P$$

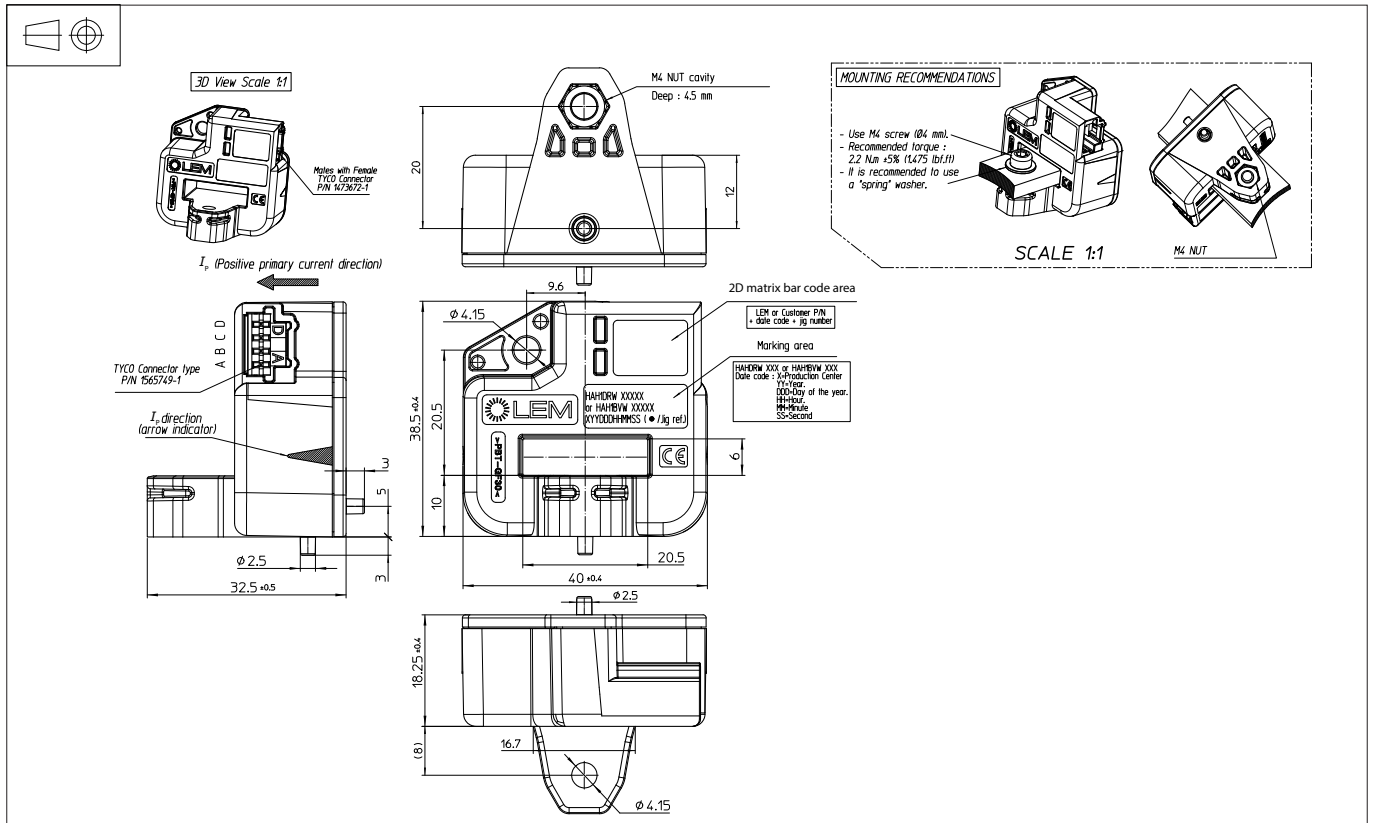|	
a	constant
b	constant
c_H	Hall coefficient
d	thickness of the Hall plate
I_H	current across the Hall plates

The measurement signal U_H amplified to supply the user output voltage or current.

Fig. 1: Principle of the open loop transducer.

Dimensions (in mm)
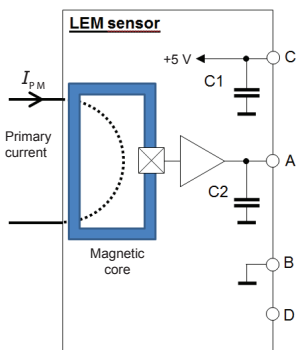

Mechanical characteristics

- Plastic case   PBT GF30

- Magnetic core   FeSi wound core

- Mass   57 g ±5 %

- Pins   Brass tin plated

- IP level   IPx2.

Mounting recommendation

- Mating connector type   TYCO connector P/N 1473672-1

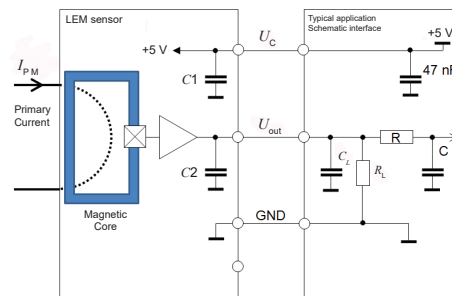- Assembly torque   2.2 N·m ±5 %

Electronic schematic

Components list		
IC	Hall sensor ASIC	
C1	Decoupling capacitor	100 nF
C2	EMC protection capacitor	68 nF

Pin out	
A	U_{out}
B	GND
C	U_C (5 V)
D	not connected

Remark

- U_{out} > U_o when I_P flows in the positive direction (see arrow on drawing).

System architecture (example)

C_L < 100 nF EMC protection (optional)
RC Low pass filter (optional)

On board diagnostic

R_L > 10 kΩ. Resistor for signal line diagnostic (optional)

U_{out}	Diagnostic
Open circuit	U_{IN} ≤ 0.15 V
Short GND	U_{IN} ≤ 0.15 V

Absolute ratings (not operating)

Parameter	Symbol	Unit	Specification Min	Specification Typical	Specification Max	Conditions
Maximum supply voltage	$U_{C\,max}$	V			14	
Maximum supply voltage	$U_{C\,max}$	V	−14			
Maximum output voltage	$U_{out\,max}$	V	−14		14	U_{out} Reverse / Forward voltage
Maximum output current	$I_{out\,max}$	mA	−10		10	
Ambient storage temperature	T_S	°C	−40		125	
Electrostatic discharge voltage (HBM)	$U_{ESD\,HBM}$	kV			8	
Maximum admissible vibration (random RMS)	γ_{max}	m·s^{-2}			96.6	10 to 2000 Hz, −40 °C to 125 °C
RMS voltage for AC insulation test	U_d	kV			2.5	50 Hz, 1 min
Creepage distance	d_{Cp}	mm	4.85			
Clearance	d_{Cl}	mm	4.85			
Comparative tracking index	CTI			PLC3		

Operating characteristics in nominal range ($I_{P\,N}$)

Parameter	Symbol	Unit	Specification Min	Specification Typical	Specification Max	Conditions
Electrical Data						
Primary current, measuring range	$I_{P\,M}$	A	−400		400	
Primary nominal RMS current	$I_{P\,N}$	A	−400		400	
Supply voltage	U_C	V	4.5	5	5.5	
Ambient operating temperature	T_A	°C	−40		125	
Output voltage	U_{out}	V	$U_{out} = (U_C/5) \times (U_o + S \times I_P)$			
Sensitivity	S	mV/A		5		@ T_A = 25 °C
Offset voltage	U_O	V		2.5		
Output resolution		mV		2.5		
Output clamping high voltage	$U_{S\,Z}$		4.74			@ U_C = 5 V
Output clamping low voltage	$U_{S\,Z}$				0.26	@ U_C = 5 V
Current consumption	I_C	mA		7		@ T_A = 25 °C, @ U_C = 5 V
					10	
Load resistance	R_L	KΩ	10			
Output internal resistance	R_{out}	Ω		1		@ T_A = 25 °C
					10	
Performance Data						
Ratiometricity error	ε_r	%		±0.2		
Sensitivity error	ε_S	%		±1		@ T_A = 25 °C, @ U_C = 5 V
Electrical offset voltage	$U_{O\,E}$	mV		±2.5		@ T_A = 25 °C, @ U_C = 5 V
Magnetic offset voltage	$U_{O\,M}$	mV		±2		@ U_C = 5 V, @ T_A = 25 °C
Linearity error	ε_L	%	−1		1	% of full scale
Average temperature coefficient of $U_{O\,E}$	$TCU_{O\,E\,AV}$	mV/°C		±0.06		
Average temperature coefficient of S	TCS_{AV}	%/°C		±0.02		
Delay time @ 90 %	$t_{D\,90}$	ms			10	
Frequency bandwidth	BW	Hz		70		@ −3 dB
Peak-to-peak noise voltage	$U_{no\,pp}$	mV			10	DC to 1 MHz
Output RMS noise voltage	U_{no}	mV			1.6	
Start-up time	t_{start}	ms			1	
Setting time after overload	t_s	ms			10	

Total error ε_{tot}

Total error ε_{tot} **@** U_C **= 5 V (−40 °C ≤** T_A **≤ 125 °C)**
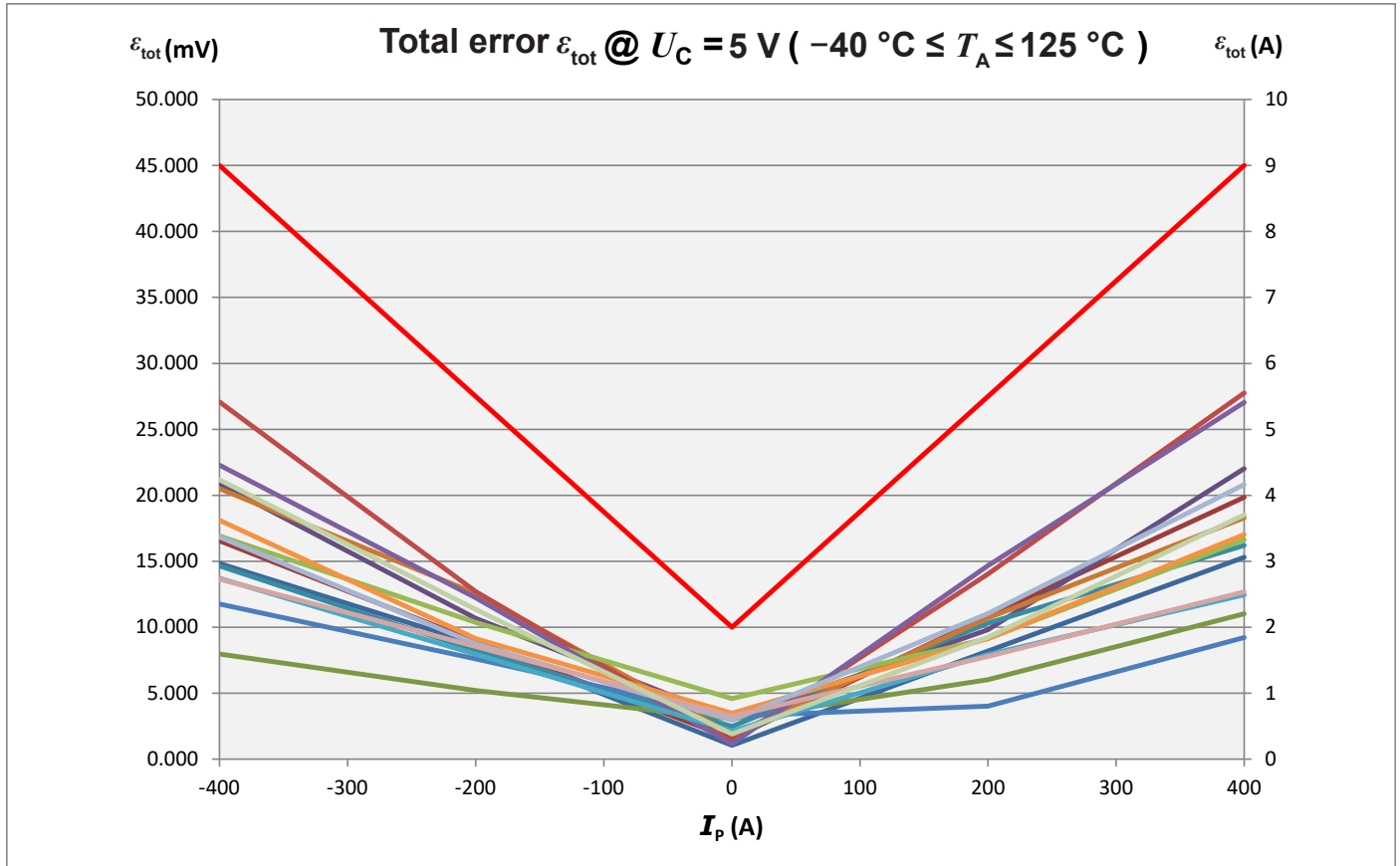
I_P (A)	Total error ε_{tot} specification					
	Typical values T_A = 25 °C, U_c = 5 V			Maximum values −40 °C ≤ T_A ≤ 125 °C, U_c = 5 V		
−400	25 mV	5.00 A	1.25 %	45 mV	9.00 A	2.25 %
0	7 mV	1.40 A	0.35 %	10 mV	2.00 A	0.50 %
400	25 mV	5.00 A	1.25 %	45 mV	9.00 A	2.25 %

PERFORMANCES PARAMETERS DEFINITIONS

Primary current definition:

① Primary current nominal ($I_{P\,N}$)

② Primary current, measuring range ($I_{P\,M}$)
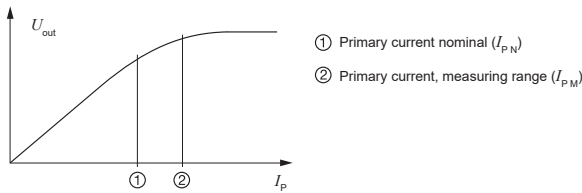
Definition of typical, minimum and maximum values:

Minimum and maximum values for specified limiting and safety conditions have to be understood as such as values shown in "typical" graphs. On the other hand, measured values are part of a statistical distribution that can be specified by an interval with upper and lower limits and a probability for measured values to lie within this interval. Unless otherwise stated (e.g. "100 % tested"), the LEM definition for such intervals designated with "min" and "max" is that the probability for values of samples to lie in this interval is 99.73 %. For a normal (Gaussian) distribution, this corresponds to an interval between −3 sigma and +3 sigma. If "typical" values are not obviously mean or average values, those values are defined to delimit intervals with a probability of 68.27 %, corresponding to an interval between −sigma and +sigma for a normal distribution. Typical, minimum and maximum values are determined during the initial characterization of a product.

Output noise voltage:

The output voltage noise is the result of the noise floor of the Hall elements and the linear amplifier.

Magnetic offset:

The magnetic offset is the consequence of an any current on the primary side. It's defined after a stated excursion of primary current.
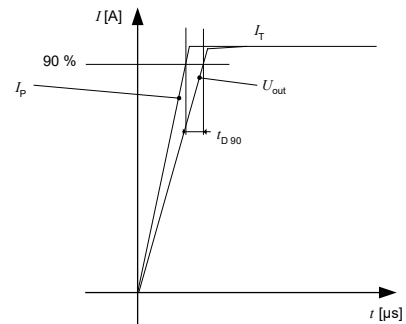
Linearity:

The maximum positive or negative discrepancy with a reference straight line $U_{out} = f(I_P)$.
Unit: linearity (%) expressed with full scale of $I_{P\,N}$.
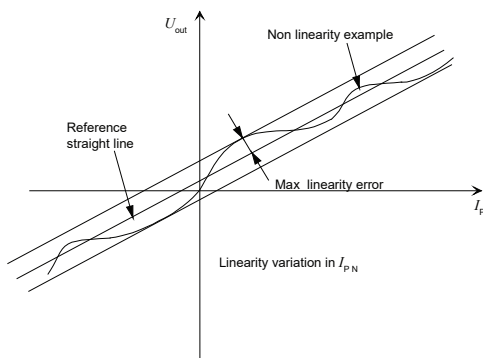
Delay time $t_{D\,90}$:

The time between the primary current signal ($I_{P\,N}$) and the output signal reach at 90 % of its final value.

Sensitivity:

The transducer's sensitivity S is the slope of the straight line $U_{out} = f(I_P)$, it must establish the relation:

$$U_{out}(I_P) = U_C/5\,(S \times I_P + U_O)$$

Offset with temperature:

The error of the offset in the operating temperature is the variation of the offset in the temperature considered with the initial offset at 25 °C.

The offset variation $I_{O\,T}$ is a maximum variation the offset in the temperature range:

$$I_{O\,T} = I_{O\,E}\,max - I_{O\,E}\,min$$

The offset drift $TCI_{O\,E\,AV}$ is the $I_{O\,T}$ value divided by the temperature range.

Sensitivity with temperature:

The error of the sensitivity in the operating temperature is the relative variation of sensitivity with the temperature considered with the initial offset at 25 °C.

The sensitivity variation S_T is the maximum variation (in ppm or %) of the sensitivity in the temperature range:
S_T = (Sensitivity max − Sensitivity min) / Sensitivity at 25 °C.

The sensitivity drift TCS_{AV} is the S_T value divided by the temperature range. Deeper and detailed info available is our LEM technical sales offices (www.lem.com).

Offset voltage @ I_P = 0 A:

The offset voltage is the output voltage when the primary current is zero. The ideal value of U_O is $U_C/2$. So, the difference of $U_O - U_C/2$ is called the total offset voltage error. This offset error can be attributed to the electrical offset (due to the resolution of the ASIC quiescent voltage trimming), the magnetic offset, the thermal drift and the thermal hysteresis. Deeper and detailed info available is our LEM technical sales offices (www.lem.com).

Environmental test specifications:

Refer to LEM GROUP test plan laboratory CO.11.11.515.0 with "Tracking_Test Plan_Auto" sheet.

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Name	Standard
CHARACTERIZATION @ 25 °C	
Sensitivity / Accuracy / Overall accuracy	LEM 98.20.00.574.0
Offset / Electrical Offset / Magnetic Offset	LEM 98.20.00.573.0
Linearity error	LEM 98.20.00.370.0
Current Consumption	LEM 98.20.00.579.0
CHARACTERIZATION WITH T °C (initial)	
Sensitivity / Accuracy / Overall accuracy	LEM 98.20.00.574.0
T °C variation of ... / Temperature Coefficient of S	LEM 98.20.00.574.0
Offset / Electrical Offset / Magnetic Offset	LEM 98.20.00.573.0
T °C variation of ... /Temperature Coefficient of Offset	LEM 98.20.00.573.0
Linearity error	LEM 98.20.00.370.0
Current Consumption	LEM 98.20.00.579.0
ELECTRICAL TESTS @ 25 °C	
Dielectric withstand Voltage test	2500 V AC / 1 min / 50 Hz
Insulation resistance test	500 V DC, time = 60 s $R_{INS} \geq 500$ MΩ Minimum
ENVIRONMENTAL TESTS (CLIMATIC)	
Thermal shock	IEC 60068-2-14 Na (01/2009)
Steady state T °C Humidity bias life test	JESD 22-A101 (03/2009)
MECHANICAL TESTS	
Vibration random in T °C	IEC 60068-2-64 (02/2008)
Shocks	IEC 60068-2-27 (02/2008)
Free Fall (Device not packaged)	IEC 60068-2-31 §5.2: method 1 (05/2008)
FINAL CHARACTERIZATION	
Characterization @ 25 °C	
Characterization with temperature	